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Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/716,175	CHEN ET AL.	
Examiner	Art Unit	
Charanjit S. Aulakh	1625	

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Class	Subclass	Date	Examiner
514	584	11/7/2005	CA
514	585	11/7/2005	CA
564	23 .	11/7/2005	CA
564	26	11/7/2005	CA
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
514	584	11/7/2005	CA	
514	585	11/7/2005	CA	
564	23	11/7/2005	CA	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
STN STRUCTURE SEARCH UPDATED	11/7/2005	CA
INVENTOR'S NAME SEARCH UPDATED	11/7/2005	CA
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